# BSCP 1207 Physics of Semiconductor Devices

## **Module-I**

## (10 Hours)

- 1. Introduction to the quantum theory of solids: Formation of energy bands, The k-space diagram (two and three dimensional representation), conductors, semiconductors and insulators.
- 2. Electrons and Holes in semiconductors: Silicon crystal structure, Donors and acceptors in the band model, electron effective mass, Density of states, Thermal equilibrium, Fermi-Dirac distribution function for electrons and holes, Fermi energy. Equilibrium distribution of electrons & holes: derivation of n and p from D(E) and f(E), Fermi level and carrier concentrations, The np product and the intrinsic carrier concentration. General theory of *n* and *p*, Carrier concentrations at extremely high and low temperatures: complete ionization, partial ionization and freeze-out. Energy-band diagram and Fermi-level, Variation of E<sub>F</sub> with doping concentration and temperature.
- 3. Motion and Recombination of Electrons and Holes: Carrier drift: Electron and hole mobilities, Mechanism of carrier scattering, Drift current and conductivity.

## Module II

- (11 Hours) 4. Motion and Recombination of Electrons and Holes (continued): Carrier diffusion: diffusion current, Total current density, relation between the energy diagram and potential, electric field. Einstein
- relationship between diffusion coefficient and mobility. Electron-hole recombination, Thermal generation. 5. **PN Junction:** Building blocks of the pn junction theory: Energy band diagram and depletion layer of a pn junction, Built-in potential; Depletion layer model: Field and potential in the depletion layer, depletionlayer width; Reverse-biased PN junction; Capacitance-voltage characteristics; Junction breakdown: peak
  - electric field. Tunneling breakdown and avalanche breakdown; Carrier injection under forward bias-Quasi-equilibrium boundary condition; current continuity equation; Excess carriers in forward-biased pn junction; PN diode I-V characteristic, Charge storage.
- 6. The Bipolar Transistor: Introduction, Modes of operation, Minority Carrier distribution, Collector current, Base current, current gain, Base width Modulation by collector current, Breakdown mechanism, Equivalent Circuit Models - Ebers - Moll Model.

## Module III

## (12 Hours)

- 7. Metal-Semiconductor Junction: Schottky Diodes: Built-in potential, Energy-band diagram, I-V characteristics, Comparison of the Schottky barrier diode and the pn-junction diode. Ohmic contacts: tunneling barrier, specific contact resistance.
- 8. MOS Capacitor: The MOS structure, Energy band diagrams, Flat-band condition and flat-band voltage, Surface accumulation, surface depletion, Threshold condition and threshold voltage, MOS C-V characteristics, Q<sub>inv</sub> in MOSFET.
- 9. MOS Transistor: Introduction to the MOSFET, Complementary MOS (CMOS) technology, V-I Characteristics, Surface mobilities and high-mobility FETs, JFET, MOSFET V<sub>t</sub>, Body effect and steep retrograde doping, pinch-off voltage,

## Text Books:

- 1. Modern Semiconductor Devices for Integrated Circuits, Chenming Calvin Hu, Pearson Education/Prentice Hall, 2009.
- 2. Semiconductor Physics and Devices, 3rd Edition, Donald A. Neamen, Tata McGraw Hill Publishing Company Limited, New Delhi.

## **Reference Books:**

- 1. Fundamentals of Semiconductor Devices, M.K. Achuthan and K.N. Bhatt, Tata McGraw Hill Publishing Company Limited, New Delhi.
- 2. Solid State Electronics Devices, 6th Edition, Ben. G. Stretman and Sanjay Banarjee, Pearson Education, New Delhi.
- 3. Physics of Semiconductor Devices, 3<sup>rd</sup> Edition, S.M. Sze and Kwok K. Ng, Wiley India Pvt. Limited, New Delhi.
- 4. Physics of Semiconductor Devices, 2<sup>nd</sup> Edition, Dillip K. Roy, University Press (India) Pvt. Ltd., Hyderabad.
- 5. Solid State Electronics Devices, D.K. Bhattacharya and Rajnish Sharma, Oxford University Press, New Delhi.